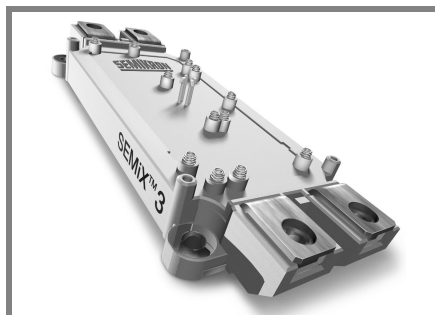


# SEMiX 353GB176HDs



SEMiX™ 3s

## Trench IGBT Modules

### SEMiX 353GB176HDs

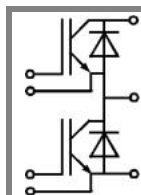
#### Target Data

#### Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

#### Typical Applications

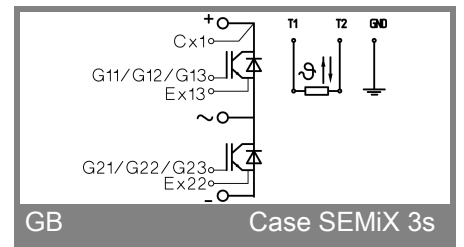
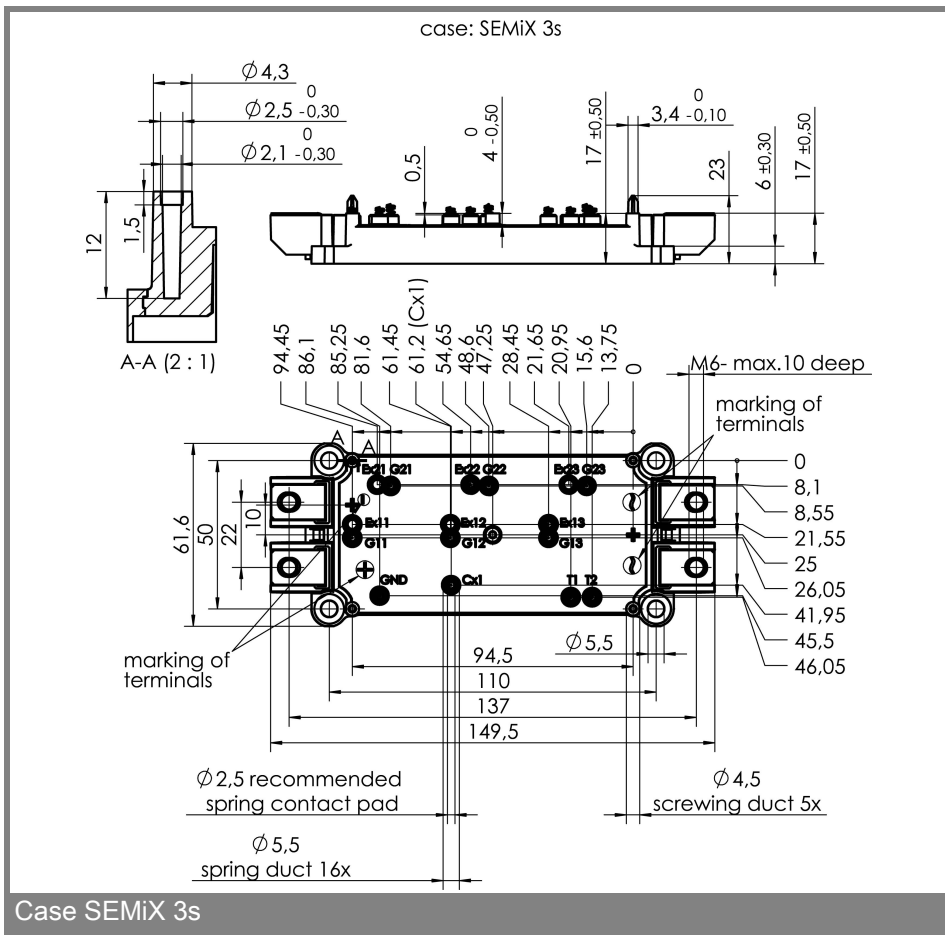
- AC inverter drives
- UPS
- Electronic welders



GB

| Absolute Maximum Ratings |                                                        | $T_c = 25^\circ\text{C}$ , unless otherwise specified |                  |
|--------------------------|--------------------------------------------------------|-------------------------------------------------------|------------------|
| Symbol                   | Conditions                                             | Values                                                | Units            |
| <b>IGBT</b>              |                                                        |                                                       |                  |
| $V_{CES}$                |                                                        | 1700                                                  | V                |
| $I_C$                    | $T_c = 25 (80)^\circ\text{C}$                          | 380 (270)                                             | A                |
| $I_{CRM}$                | $T_c = 25 (80)^\circ\text{C}$ , $t_p = 1 \text{ ms}$   | 760 (540)                                             | A                |
| $V_{GES}$                |                                                        | $\pm 20$                                              | V                |
| $T_{vj}$ ( $T_{stg}$ )   | $T_{OPERATION} \leq T_{stg}$                           | - 40 ... + 150 (125)                                  | $^\circ\text{C}$ |
| $V_{isol}$               | AC, 1 min.                                             | 4000                                                  | V                |
| <b>Inverse diode</b>     |                                                        |                                                       |                  |
| $I_F = -I_C$             | $T_c = 25 (80)^\circ\text{C}$                          | 310 (210)                                             | A                |
| $I_{FRM}$                | $T_c = 25 (80)^\circ\text{C}$ , $t_p = 1 \text{ ms}$   | 760 (540)                                             | A                |
| $I_{FSM}$                | $t_p = 10 \text{ ms}$ ; sin.; $T_j = 25^\circ\text{C}$ |                                                       | A                |

| Characteristics                |                                                                                                  | $T_c = 25^\circ\text{C}$ , unless otherwise specified |            |            |               |
|--------------------------------|--------------------------------------------------------------------------------------------------|-------------------------------------------------------|------------|------------|---------------|
| Symbol                         | Conditions                                                                                       | min.                                                  | typ.       | max.       | Units         |
| <b>IGBT</b>                    |                                                                                                  |                                                       |            |            |               |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}$ , $I_C = 9 \text{ mA}$                                                         | 5,2                                                   | 5,8        | 6,4        | V             |
| $I_{CES}$                      | $V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25 (125)^\circ\text{C}$                               |                                                       |            | 1,8        | mA            |
| $V_{CE(TO)}$                   | $T_j = 25 (125)^\circ\text{C}$                                                                   |                                                       | 1 (0,9)    | 1,2 (1,1)  | V             |
| $r_{CE}$                       | $V_{GE} = 15 \text{ V}$ , $T_j = 25 (125)^\circ\text{C}$                                         |                                                       | 4,4 (6,9)  | 5,5 (8)    | m $\Omega$    |
| $V_{CE(sat)}$                  | $I_C = 225 \text{ A}$ , $V_{GE} = 15 \text{ V}$ ,<br>$T_j = 25 (125)^\circ\text{C}$ , chip level |                                                       | 2 (2,45)   | 2,45 (2,9) | V             |
| $C_{ies}$                      | under following conditions                                                                       |                                                       | 17,1       |            | nF            |
| $C_{oes}$                      | $V_{GE} = 0$ , $V_{CE} = 25 \text{ V}$ , $f = 1 \text{ MHz}$                                     |                                                       | 0,8        |            | nF            |
| $C_{res}$                      |                                                                                                  |                                                       | 0,7        |            | nF            |
| $L_{CE}$                       |                                                                                                  |                                                       | 20         |            | nH            |
| $R_{CC'+EE'}$                  | resistance, terminal-chip, $T_c = 25 (125)^\circ\text{C}$                                        |                                                       | 0,8 (1,2)  |            | m $\Omega$    |
| $t_{d(on)}/t_r$                | $V_{CC} = 1200 \text{ V}$ , $I_C = 225 \text{ A}$                                                |                                                       |            |            | ns            |
| $t_{d(off)}/t_f$               | $V_{GE} = \pm 15 \text{ V}$                                                                      |                                                       |            |            | ns            |
| $E_{on} (E_{off})$             | $R_{Gon} = R_{Goff} = \Omega$ , $T_j = 125^\circ\text{C}$                                        |                                                       | 140 (80)   |            | mJ            |
| <b>Inverse diode</b>           |                                                                                                  |                                                       |            |            |               |
| $V_F = V_{EC}$                 | $I_F = 225 \text{ A}$ ; $V_{GE} = 0 \text{ V}$ ; $T_j = 25 (125)^\circ\text{C}$ , chip level     |                                                       | 1,7 (1,7)  | 1,9 (1,9)  | V             |
| $V_{(TO)}$                     | $T_j = 25 (125)^\circ\text{C}$                                                                   |                                                       | 1,1 (0,9)  | 1,3 (1,1)  | V             |
| $r_T$                          | $T_j = 25 (125)^\circ\text{C}$                                                                   |                                                       | 2,7 (3,6)  | 2,7 (3,6)  | m $\Omega$    |
| $I_{RRM}$                      | $I_F = 225 \text{ A}$ ; $T_j = 25 (125)^\circ\text{C}$                                           |                                                       |            |            | A             |
| $Q_{rr}$                       | $di/dt = \text{A}/\mu\text{s}$                                                                   |                                                       |            |            | $\mu\text{C}$ |
| $E_{rr}$                       | $V_{GE} = 0 \text{ V}$                                                                           |                                                       |            |            | mJ            |
| <b>Thermal characteristics</b> |                                                                                                  |                                                       |            |            |               |
| $R_{th(j-c)}$                  | per IGBT                                                                                         |                                                       |            | 0,078      | K/W           |
| $R_{th(j-c)D}$                 | per Inverse Diode                                                                                |                                                       |            | 0,166      | K/W           |
| $R_{th(j-c)FD}$                | per FWD                                                                                          |                                                       |            |            | K/W           |
| $R_{th(c-s)}$                  | per module                                                                                       |                                                       | 0,04       |            | K/W           |
| <b>Temperature sensor</b>      |                                                                                                  |                                                       |            |            |               |
| $R_{25}$                       | $T_c = 25^\circ\text{C}$                                                                         |                                                       | 5 $\pm$ 5% |            | k $\Omega$    |
| $B_{25/85}$                    | $R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]$ ; T[K]; B                                                     |                                                       | 3420       |            | K             |
| <b>Mechanical data</b>         |                                                                                                  |                                                       |            |            |               |
| $M_s/M_t$                      | to heatsink (M5) / for terminals (M6)                                                            | 3/2,5                                                 |            | 5 / 5      | Nm            |
| w                              |                                                                                                  |                                                       | 289        |            | g             |



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.